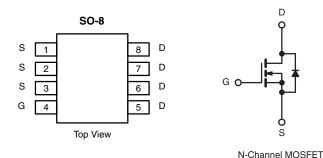


N-Channel 100-V (D-S) Super Trench Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω) Max.	I _D (A) ^a	Q _g (Typ.)		
100	0.0082 at V _{GS} = 10 V	15.5			
	0.0095 at V _{GS} = 7.5 V	14.8	27.9 nC		
	0.0105 at V _{GS} = 6.0 V	14.0			



FEATURES

- Super Trench technology Power MOSFET
- Excellent gate charge x Rds (on) product(FOM)
- Very low on-resfistance Rds (on)
- 100 % R_g and UIS Tested

APPLICATIONS

- DC/DC Primary Side Switch
- Telecom/Server
- Motor Drive Control
- Synchronous Rectification

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	100	V
Gate-Source Voltage		V _{GS}	± 20	V
	T _C = 25 °C	I _D	15.5	
Constitutions Design Constants (T 150 °C)	T _C = 70 °C		13	
Continuous Drain Current ($T_J = 150 \ ^{\circ}C$)	T _A = 25 °C		10.2 ^{b, c}	
	T _A = 70 °C		7.4 ^{b, c}	
Pulsed Drain Current (t = 300 μs)		I _{DM}	70	A
	T _C = 25 °C	- I _S	7	
Continuous Source-Drain Diode Current	T _A = 25 °C		3.1 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	30	
Avalanche Energy		E _{AS}	45	mJ
	T _C = 25 °C		7.8	
Maximum Dawar Disaination	T _C = 70 °C	– P _D	5	w
Maximum Power Dissipation	T _A = 25 °C		3.5 ^{b, c}	VV
	T _A = 70 °C		2.2 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS Parameter Maximum Symbol Typical Unit Maximum Junction-to-Ambient^{b, d} $t \le 10 \text{ s}$ 35 R_{thJA} 29 °C/W 13 16 Maximum Junction-to-Foot (Drain) Steady State R_{thJF}

Notes:

a. Based on $T_C = 25$ °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under steady state conditions is 80 °C/W.

FDS86140

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	100			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050		67		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I _D = 250 μA		- 6.4			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	2		3.3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μΑ	
		V_{DS} = 100 V, V_{GS} = 0 V, T_{J} = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, $V_{GS} = 10$ V	30			Α	
		V _{GS} = 10 V, I _D = 15 A		0.0082			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 12 A		0.0095	095 Ω		
		V _{GS} = 6.0 V, I _D = 10 A		0.0105		1	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		54		S	
Dynamic ^b		•				1	
Input Capacitance	C _{iss}			3410		pF	
Output Capacitance	C _{oss}	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		790			
Reverse Transfer Capacitance	C _{rss}			160			
Total Gate Charge		$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		45.6	69		
	Qg			27.9	42	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_{D} = 10 \text{ A}$		8.5			
Gate-Drain Charge	Q _{gd}			9.2			
Output Charge	Q _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		63	95		
Gate Resistance	Rg	f = 1 MHz	0.4	1.3	2.6	Ω	
Turn-On Delay Time	t _{d(on)}			16	32		
Rise Time	t _r	V_{DD} = 50 V, R_L = 5 Ω		11	22		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ 10 A, V_{GEN} = 7.5 V, R_g = 1 Ω		35	70		
Fall Time	t _f			10	20		
Turn-On Delay Time	t _{d(on)}			14	28	ns	
Rise Time	t _r	V_{DD} = 50 V, R_L = 5 Ω		10	20	-	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 10 A, V_GEN = 10 V, R_g = 1 Ω		36	70		
Fall Time	t _f			10	20		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			7		
Pulse Diode Forward Current ^a	I _{SM}				70	70 A	
Body Diode Voltage	V _{SD}	I _S = 5 A		0.75	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			49	95	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			58	115	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^\circ\text{C}$		21		1	
Reverse Recovery Rise Time	t _b			28		ns	

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



T_C = - 55 °C

5.6

4.2

60

75

100

80

 $V_{GS} = 10 V$

 $V_{GS} = 6 V$

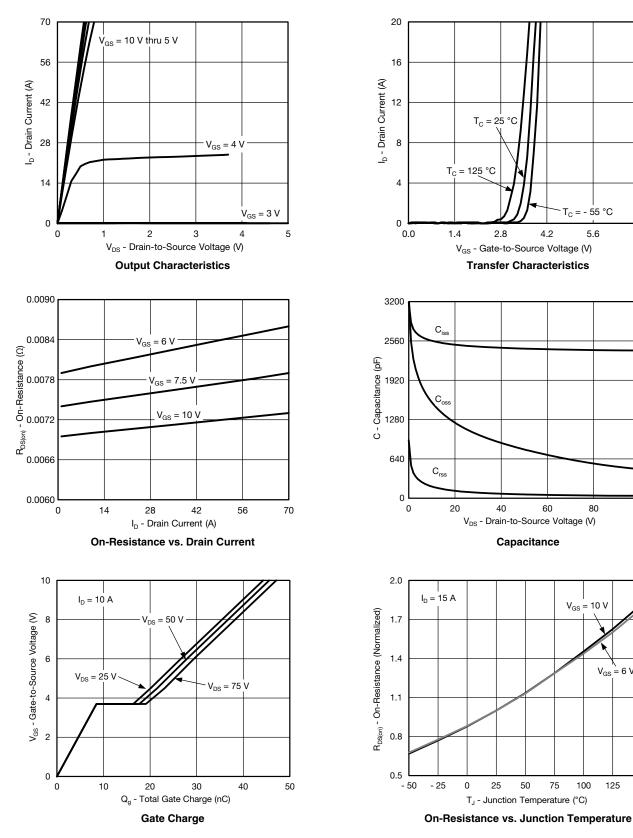
125

150

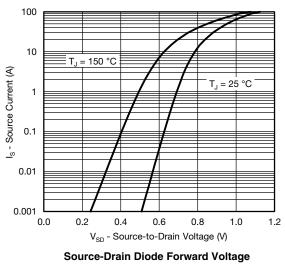
100

7.0







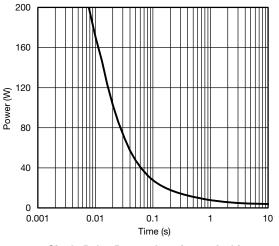


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

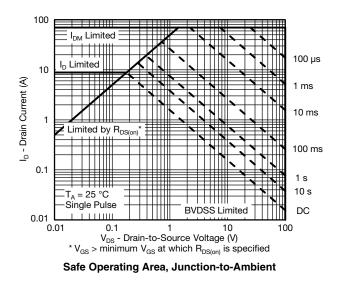
0.4 0.2 V_{GS(th)} - Variance (V) 0 - 0.2 $I_D = 5 \text{ mA}$ - 0.4 = 250 µA I_D - 0.6 - 0.8 - 50 - 25 0 25 50 75 100 125 150 T_J - Temperature (°C) **Threshold Voltage**

0.05 I_D = 15 A 0.04 $R_{DS(on)}$ - On-Resistance (Ω) 0.03 0.02 T_J = 125 °C 0.01 T_J = 25 °C 0.00 0 6 8 2 4 10 V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

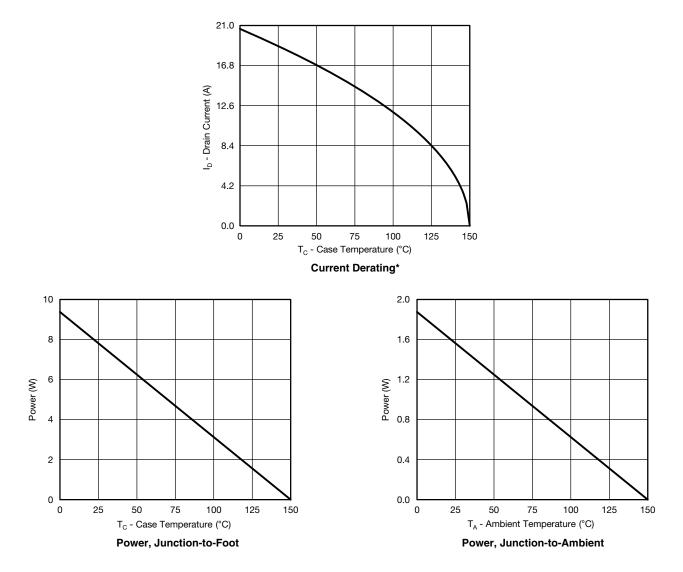


Single Pulse Power, Junction-to-Ambient



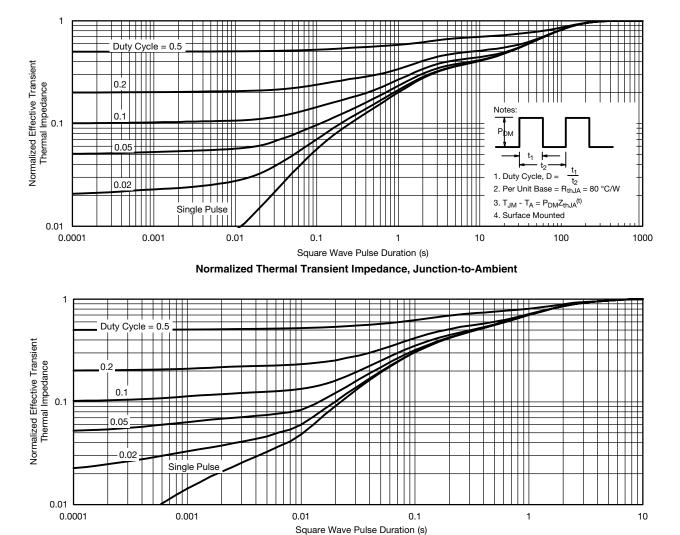


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Foot

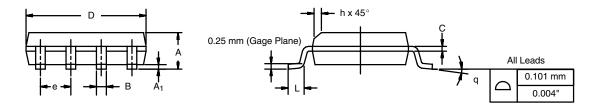
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

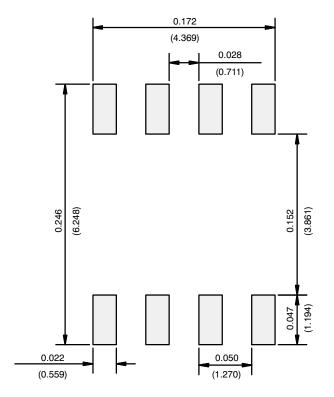




	MILLIMETERS		INCHES		
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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